

Search Notes

Application/Control No.

10/717,870

Examiner

Emeka Ebirim

Applicant(s)/Patent under
Reexamination

BEYER ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	1-10	5/26/2006	EE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	5/26/2006	EE
Consulted Mohammad Ali (primary)	5/26/2006	EE
Google Scholar	5/26/2006	EE
ACM	5/26/2006	EE
Consulted Pham Khanh (primary)	5/24/2006	EE